

Search Notes

Application/Control No.

10/777,026

Examiner

Binh X. Tran

Applicant(s)/Patent under
Reexamination

KAWAGUCHI ET AL.

Art Unit

1792

SEARCHED

Class	Subclass	Date	Examiner
216	67	1/18/2008	BT
216	68	1/18/2008	BT
216	69	1/18/2008	BT
216	73	1/18/2008	BT
438	715	1/18/2008	BT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
216	67	1/18/2008	BT
216	68	1/18/2008	BT
216	69	1/18/2008	BT
216/73 438/715		1/18/2008	BT

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated search using databases in EAST	1/18/2008	BT